Notice of References Cited Application/Control No. 10/573,968 Applicant(s)/Patent Under Reexamination YOSHIMURA ET AL. Examiner Hai C. Pham 2861 Applicant(s)/Patent Under Reexamination YOSHIMURA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0265211	12-2005	Nakane et al.	369/275.1
*	В	US-7,082,094	07-2006	Morishima et al.	369/116
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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